

N-CHANNEL MOSFET

MTN3418BN3

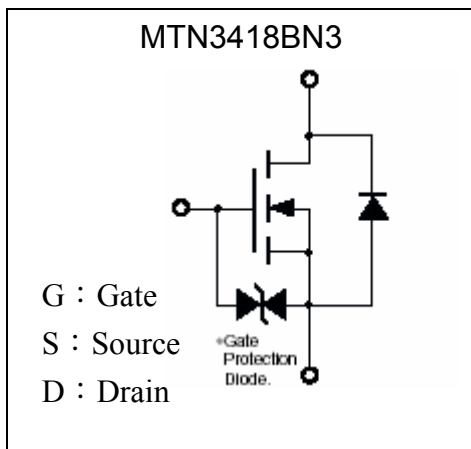
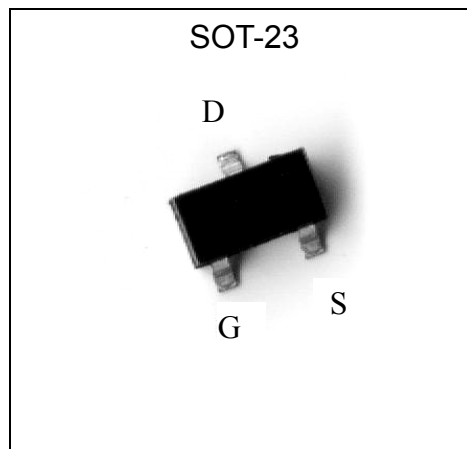
BV_{DSS}	30V
I_D	1.7A
$R_{DS(on)(max)}$	450m Ω

Description

The MTN3418BN3 is a N-channel enhancement-mode MOSFET.

Features

- Low on-resistance
- High speed switching
- Low-voltage drive(2.5V)
- Easily designed drive circuits
- Pb-free package

Symbol

Outline

Absolute Maximum Ratings (Ta=25°C)

Parameter		Symbol	Limits	Unit
Drain-Source Voltage		V_{DSS}	30	V
Gate-Source Voltage		V_{GSS}	±20	V
Drain Current	Continuous	I_D	1.7	A
	Pulsed	I_{DP}	6.8 *1	A
Total Power Dissipation		P_D	900 *2	mW
ESD susceptibility			400 *3	V
Channel Temperature		T_{CH}	+150	°C
Storage Temperature		T_{stg}	-55~+150	°C



- Note : *1. Pulse Width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$
 *2. When the device is mounted on a ceramic board with area measuring $30\text{mm} \times 30\text{mm} \times 0.8\text{mm}$
 *3. Human body model, $1.5\text{k}\Omega$ in series with 100pF

Thermal Performance

Parameter	Symbol	Limit	Unit
Thermal Resistance, Junction-to-Ambient	Rth,ja	139	$^{\circ}\text{C}/\text{W}$

Note : Surface mounted on a ceramic board with area measuring $30\text{mm} \times 30\text{mm} \times 0.8\text{mm}$, $350^{\circ}\text{C}/\text{W}$ when mounted on minimum copper pad.

Electrical Characteristics (Ta=25°C)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS} *	30	-	-	V	V _{GS} =0, I _D =10 μA
V _{GS(th)}	1	-	2.5	V	V _{DS} =V _{GS} , I _D =250 μA
I _{GSS}	-	-	± 10	μA	V _{GS} = $\pm 20\text{V}$, V _{DS} =0
I _{DSS}	-	-	100	nA	V _{DS} =30V, V _{GS} =0
R _{DS(ON)} *	-	290	400	m Ω	I _D =700mA, V _{GS} =10V
	-	310	450		I _D =400mA, V _{GS} =4V
	-	260	400		I _D =170mA, V _{GS} =10V
	-	280	400		I _D =170mA, V _{GS} =4V
G _{FS}	-	2	-	S	V _{DS} =10V, I _D =700mA
Dynamic					
C _{iss}	-	527	-	pF	V _{DS} =10V, V _{GS} =0, f=1MHz
C _{oss}	-	23	-		
C _{rss}	-	16	-		
td(ON)	-	8.8	-	ns	V _{DD} =15V, I _D =0.7A, V _{GS} =10V, R _{GEN} =50 Ω
tr	-	2.6	-		
td(OFF)	-	35.5	-		
tf	-	5.2	-		
Q _g	-	3.6	-	nC	V _{DD} =10V, I _D =1.4A, V _{GS} =10V
Q _{gs}	-	1.8	-		
Q _{gd}	-	0.3	-		
Source-Drain Diode					
*V _{SD}	-	-	1	V	V _{GS} =0V, I _{SD} =1A

*Pulse Test : Pulse Width $\leq 380\mu\text{s}$, Duty Cycle $\leq 2\%$

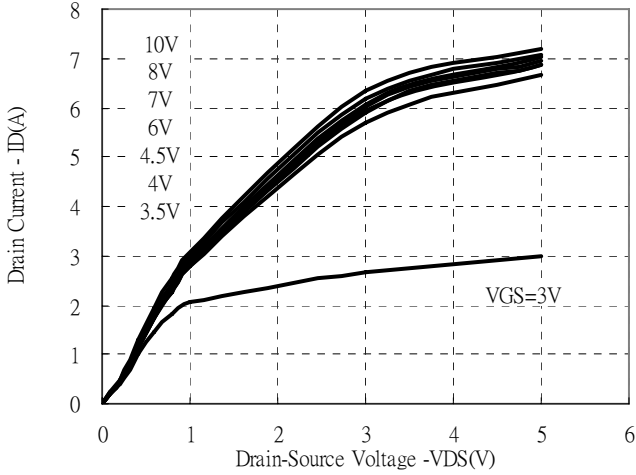
Ordering Information

Device	Package	Shipping	Marking
MTN3418BN3	SOT-23 (Pb-free)	3000 pcs / Tape & Reel	SA

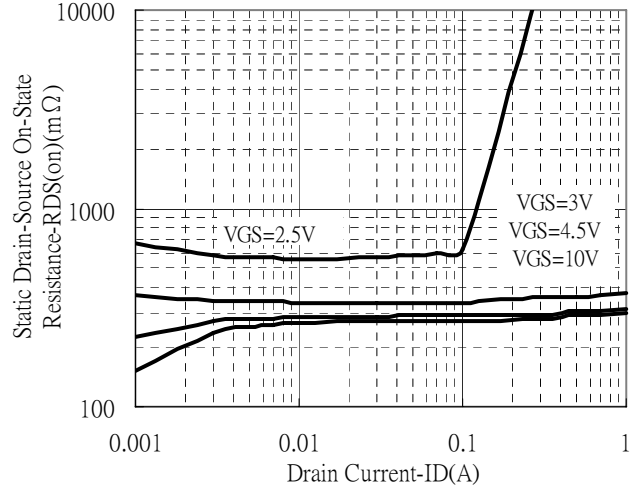


Typical Characteristics

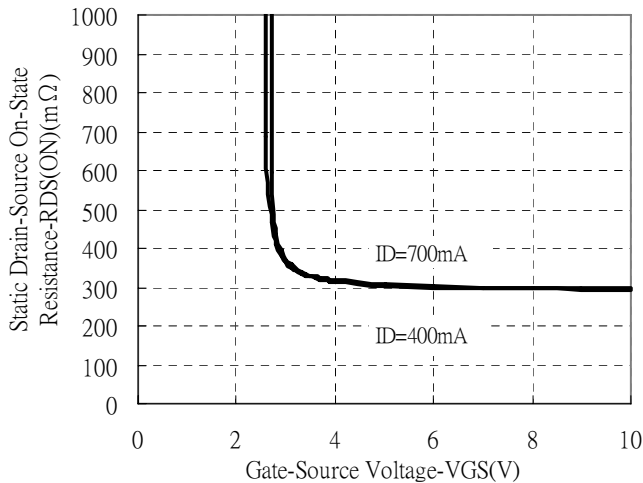
Typical Output Characteristics



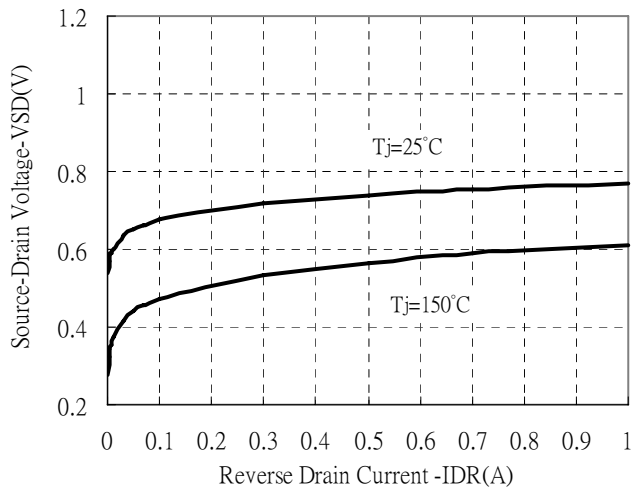
Static Drain-Source On-State resistance vs Drain Current



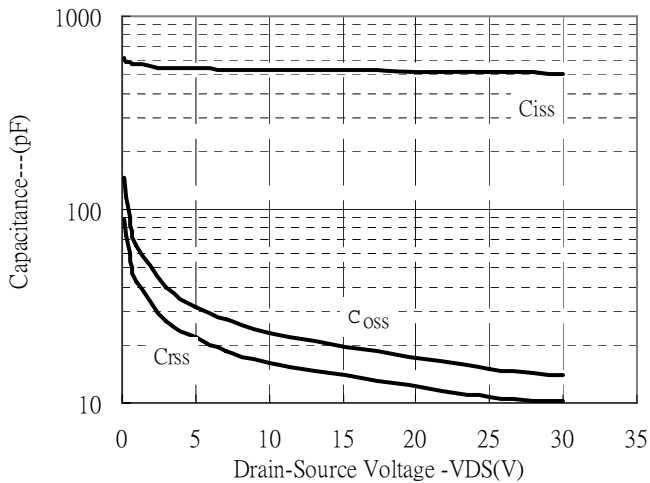
Static Drain-Source On-State Resistance vs Gate-Source Voltage



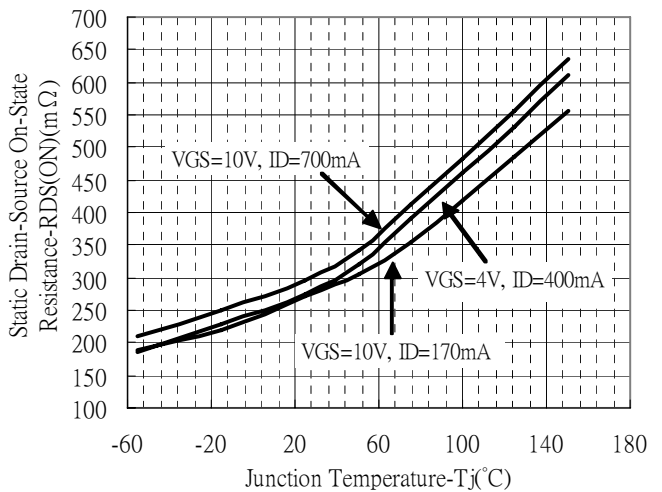
Reverse Drain Current vs Source-Drain Voltage



Capacitance vs Drain-to-Source Voltage



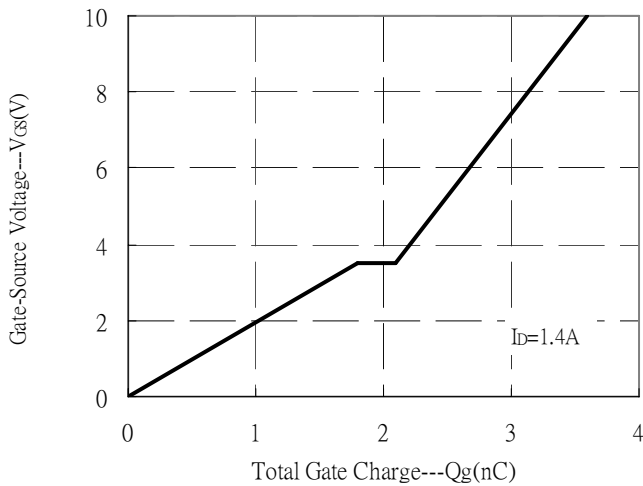
Drain-Source On-State Resistance vs Junction Temperature



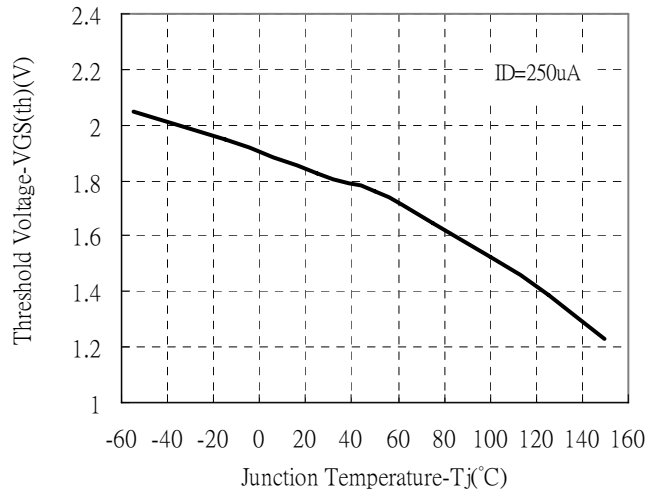


Typical Characteristics(Cont.)

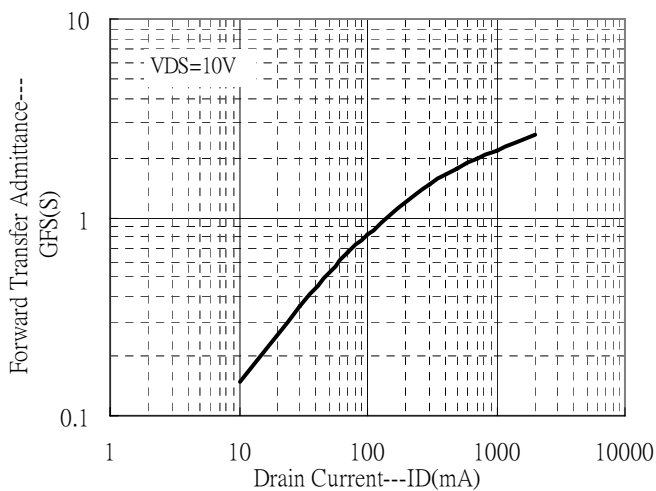
Gate Charge Characteristics



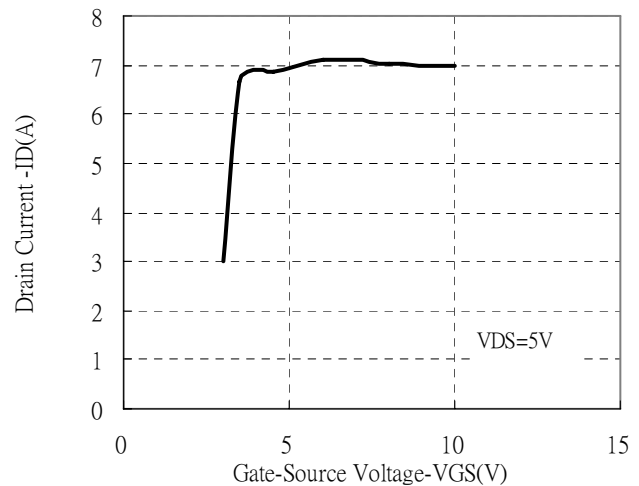
Threshold Voltage vs Junction Temperature



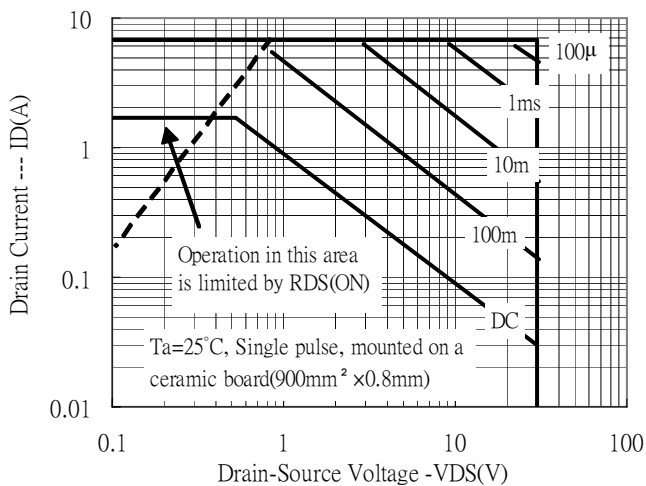
Forward Transfer Admittance vs Drain Current



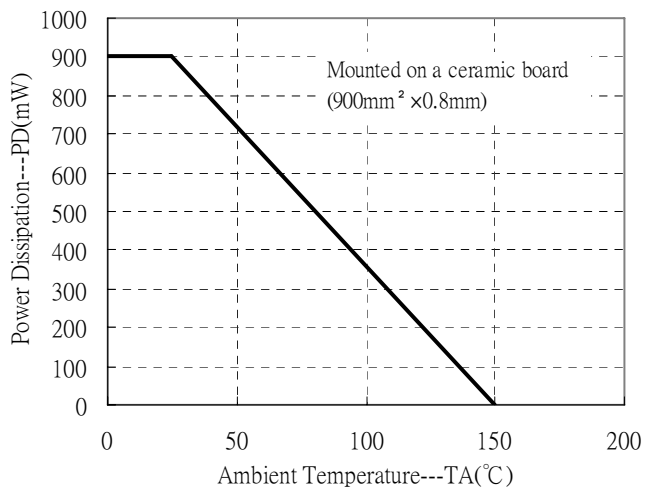
Typical Transfer Characteristics



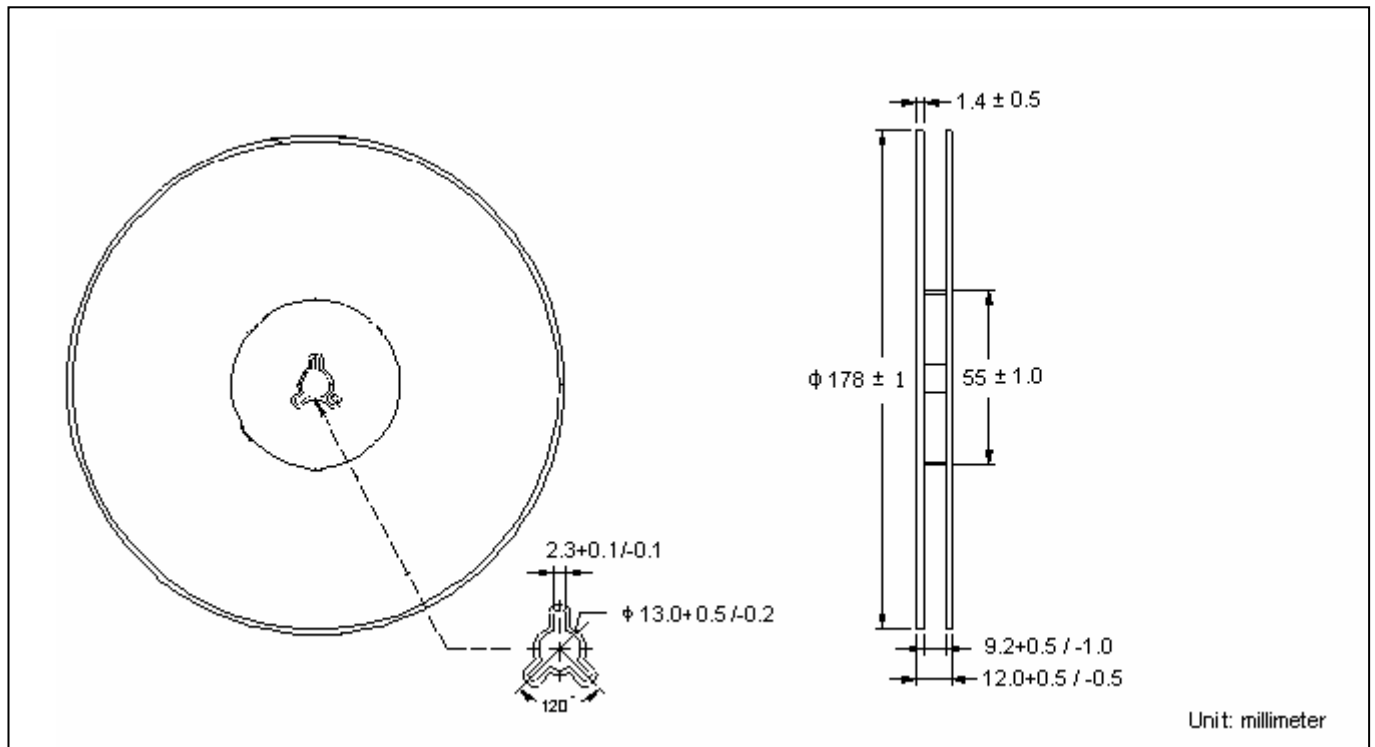
Maximum Safe Operating Area



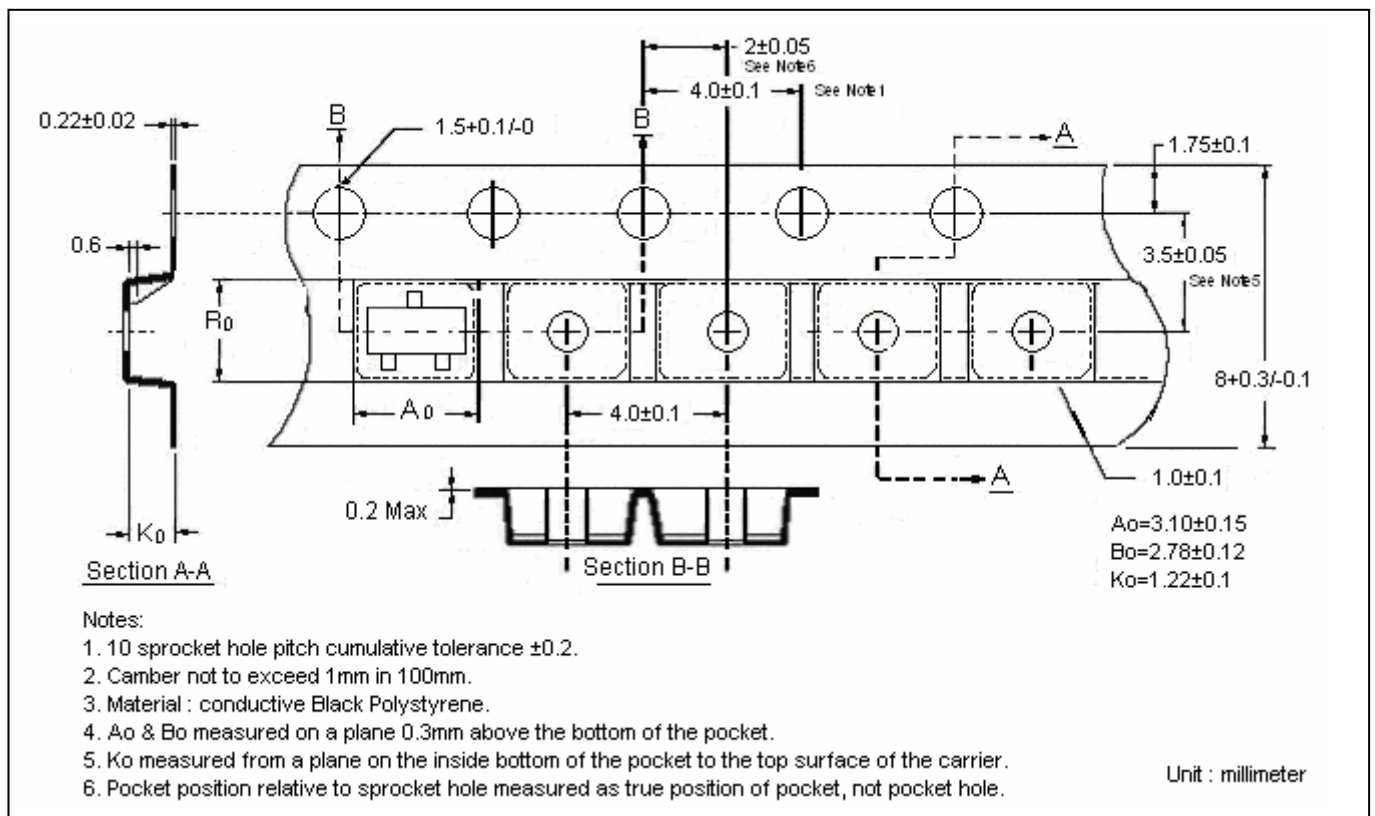
Power Derating Curve



Reel Dimension



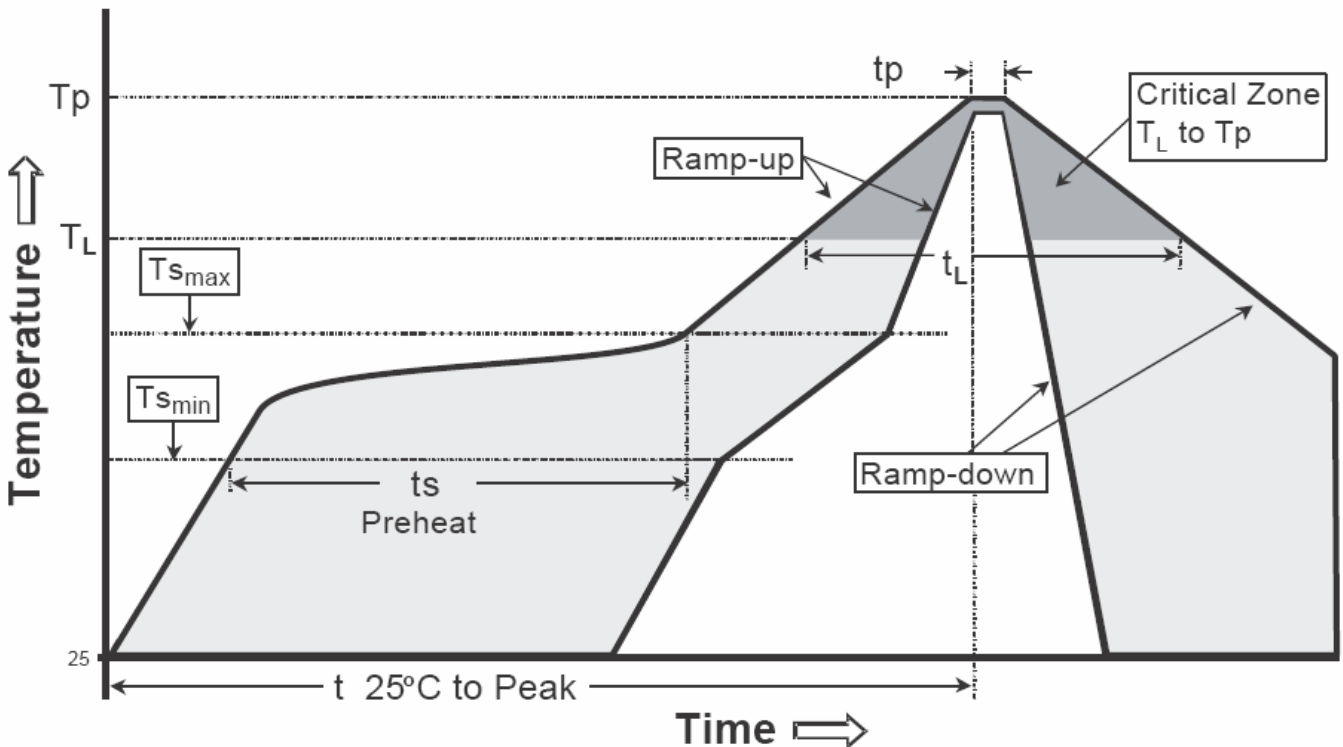
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

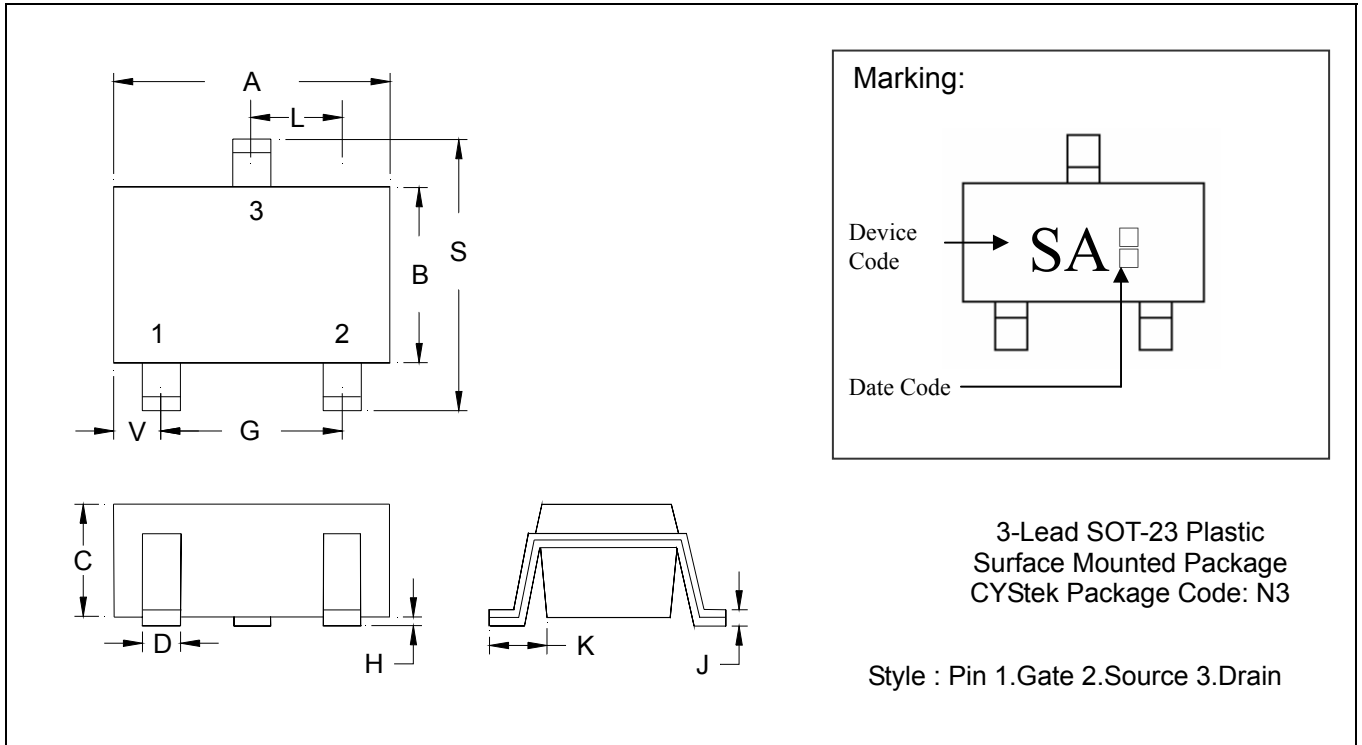
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (Ts _{max} to T _P)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _s min)	100°C	150°C
-Temperature Max(T _s max)	150°C	200°C
-Time(t _s min to t _s max)	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _P)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

SOT-23 Dimension



*:Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1102	0.1204	2.80	3.04	J	0.0035	0.0071	0.09	0.18
B	0.0472	0.0669	1.20	1.70	K	0.0276	REF	0.70	REF
C	0.0335	0.0512	0.89	1.30	L	0.0374*		0.95*	
D	0.0118	0.0197	0.30	0.50	S	0.0830	0.1161	2.10	2.95
G	0.0669	0.0910	1.70	2.30	V	0.0098	0.0256	0.25	0.65
H	0.0004	0.0040	0.01	0.10					

Notes : 1.Controlling dimension : millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material :

- Lead : Pure tin plated.
- Mold Compound : Epoxy resin family, flammability solid burning class:UL94V-0.

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